

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 293259US0PCT	SERIAL NO. 10/586,967		
LIST OF REFERENCES CITED BY APPLICANT		APPLICANT Nicolas NADAUD, et al.					
		FILING DATE September 25, 2006	GROUP 1714				
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION		
					YES	NO	
	AC	JP 2007-001833	11/30/01	Japan w/English Abstract			
	AP	JP 04-050168	11/17/00	Japan w/English Abstract			
	AQ	JP 2-11020	08/22/90	Japan w/English Abstract			
	AR	JP 0-239435	09/24/90	Japan w/English Abstract			
	AS	JP 0-538872	09/03/92	Japan		x	
	AT	JP 7-165442	05/27/95	Japan w/English Abstract			
	AU	JP 0-239740	08/17/96	Japan w/English Abstract			
		WPO-00/074440	09/12/00	WIPO w/English Abstract			
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW	Office Action dated February 22, 2011 as received in the corresponding Japanese Patent Application No. 2006-550254					
	AX						
	AY						
	AZ				<input type="checkbox"/> Additional References sheet(s) attached		
Examiner	/Ryan Coleman/			Date Considered	08/31/2011		

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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	AM						
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION		
					YES	NO	
AQ	JP 4-220995	08/19/02		Japan w/English Abstract			
AP	JP 7-172972	07/11/95		Japan w/English Abstract			
AQ	2003-500327	03/11/03		Japan w/English Abstract			
AR	WO 2004/003210	01/13/04		WIPO w/English Abstract			
AS	JP10-252005	09/25/98		Japan w/English Abstract			
AT							
AU							
AV							
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